

Switch Fabrics

Switching Technology S38.165
<http://www.netlab.hut.fi/opetus/s38165>

Switch fabrics

- Multipoint switching
- Self-routing networks
- Sorting networks
- **Fabric implementation technologies**
- Fault tolerance and reliability

Fabric implementation technologies

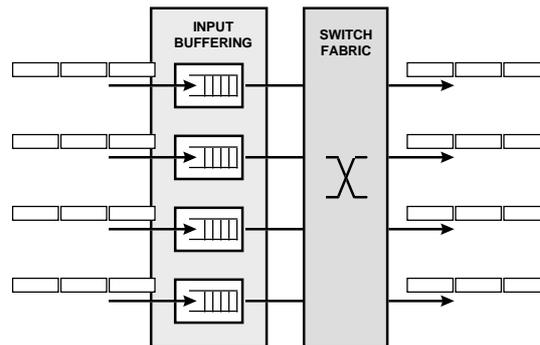
- Time division fabrics
 - Shared media
 - Shared memory
- Space division fabrics
 - Crossbar
 - Multi-stage constructions
- **Buffering techniques**

Buffering alternatives

- Input buffering
- Output buffering
- Central buffering
- Combinations
 - input-output buffering
 - central-output buffering

Input buffering

Buffer memories at the input interfaces

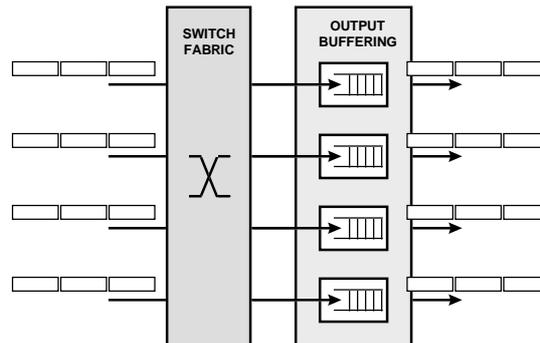


Input buffering (cont.)

- Pros
 - required memory access speed
 - in FIFO and dual-port RAM solutions equal to incoming line rate
 - in one-port RAM solutions *twice* the incoming line rate
 - Speed of switch fabric
 - multi-stages and crossbars operate at input wire speed
 - shared media fabrics operate at the aggregate speed of inputs
 - low cost solution (due to low memory speed)
- Cons
 - FIFO type of buffering => HOL problem
 - buffer size may be large (due to HOL)
 - HOL avoided by having a buffer for each output at each input

Output buffering

Buffer memories at the output interfaces

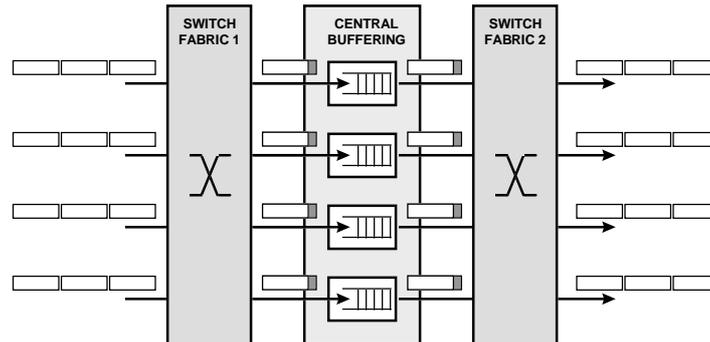


Output buffering (cont.)

- Pros
 - better throughput/delay performance than in input buffered systems
 - no HOL problem
- Cons
 - access speed of buffer memory
 - in FIFO and dual-port RAM solutions N times the incoming line rate
 - in one-port RAM solutions $N+1$ times the incoming line rate
 - high cost due to high memory speed requirement
 - switch fabric operates at the aggregate speed of inputs ($N \times$ wire speed)

Central buffering

- Buffer memory located between two switch fabrics
- shared by all inputs/outputs
 - virtual buffer for each input or output



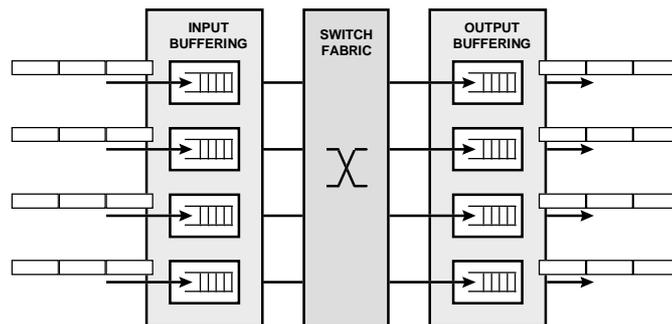
Central buffering (cont.)

- Pros
 - smaller buffer size requirement and lower average delay than in input or output buffering
 - HOL problem can be avoided
- Cons
 - speed of buffer memory
 - in dual-port RAM solutions larger than N times the incoming line rate
 - in one-port RAM solutions larger than $2 \times N$ times the incoming line rate
 - speed of switch fabric $N \times$ wire speed
 - complicated buffer control
 - high cost due to high memory speed requirement and control complexity

Input-output buffering

Input-output buffering common in QoS aware switches/routers

- inputs implement output specific buffers to avoid HOL
- outputs implement dedicated buffers for different traffic classes
- combined buffering distributes buffering complexity between inputs and outputs



© P. Raatikainen

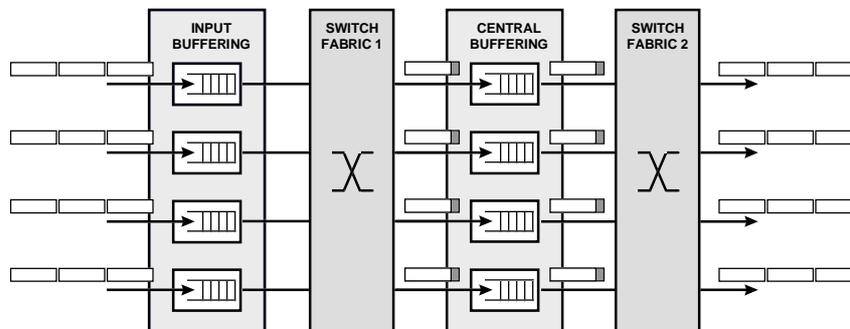
Switching Technology / 2003

7 - 11

Input-central buffering

Input-central buffering used in QoS aware switches/routers

- inputs implement output specific buffers to avoid HOL
- central buffer implements dedicated buffers for different traffic classes for each output



© P. Raatikainen

Switching Technology / 2003

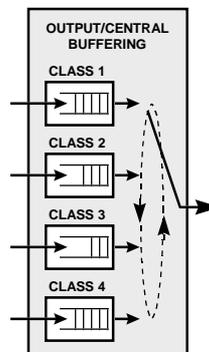
7 - 12

Summary of buffering techniques

Buffering principle	Memory space	Memory speed	Memory control	Queueing delay	Multi-casting capabilities
Input buffering	high	slow (~input rate)	simple	longest (due to HOL)	extra logic needed
Output buffering	medium	fast (~N x input rate)	simple	medium	supported
Central buffering	low	fast (~N x input rate)	complicated	shortest	supported but complex

Priorities and buffering

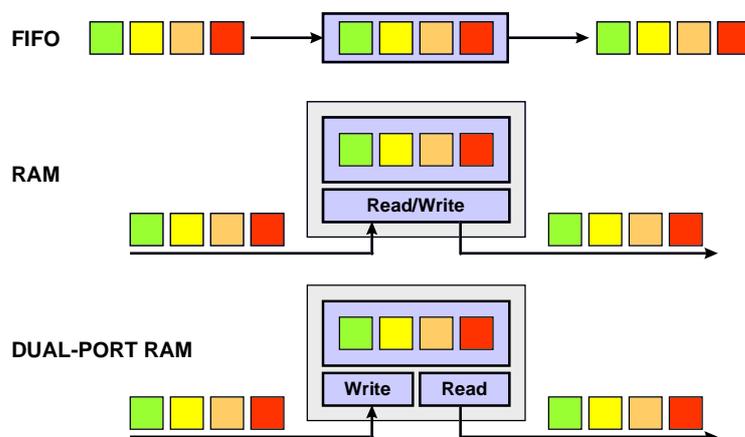
- Separate buffer for each traffic class
- A scheduler needed to control transmission data
 - highest priority served first
 - longest queue served first
 - minimization of lost packets/cells
- Priority given to high quality traffic
 - low delay and delay variation traffic
 - low loss rate traffic
 - best customer traffic
- Scheduling principles
 - round robin
 - weighted round robin
 - fair queuing
 - weighted fair queuing
 - etc.



Basic memory types for buffering

- FIFO (First-In-First-Out)
- RAM (Random Access Memory)
- Dual-port RAM

Basic memory types for buffering (cont.)



Switch fabrics

- Multipoint switching
- Self-routing networks
- Sorting networks
- Fabric implementation technologies
- **Fault tolerance and reliability**

Fault tolerance and reliability

- Definitions
- Fault tolerance of switching systems
- Modeling of tolerance and reliability

Definitions

- **Failure, malfunction** - is deviation from the intended/specified performance of a system
- **Fault** - is such a state of a device or a program which can lead to a failure
- **Error** - is an incorrect response of a program or module. An error is a indication that the module in question may be faulty, the module has received wrong input or it has been misused. An error can lead to a failure if the system is not tolerant to this sort of an error. A fault can exist without any error taking place.

Fault tolerance

- **Fault tolerance** is the ability of a system to continue its intended performance in spite of a fault or faults
- **A switching system** is an example of a fault tolerant system
- Fault tolerance always requires redundancy of some sort

Categorization of faults

- **Duration based**
 - **permanent** or stuck-at (stuck at zero or stuck at one)
 - **intermittent** - fault requires repair actions, but its impact is not always observable
 - **transient** - fault can be observed for a short period of time and disappears without repair
- **Observable or latent** (hidden)
- Based on the **scope** of the impact (serious - less serious)

Graceful degradation

- **Capability of a system to continue its functions under one or more faults, but on a reduced level of performance**
- **For example**
 - in some RAID (Redundant Array Inexpensive Disks) configurations, write speed drops in case of a disk fault, but continues on a lower level of performance even while the fault has not been repaired

Reliability and availability

- **Reliability $R(t)$** - probability that a system does not fail within time t under the condition that it was functioning correctly at $t = 0$
 - for all known man-made systems $R(t) \rightarrow 0$ when $t \rightarrow \infty$
- **Availability $A(t)$** - probability that a system will function correctly at time t
 - for a system that can be repaired $A(t)$ approaches some value asymptotically during the useful lifetime of the system

Repairable system

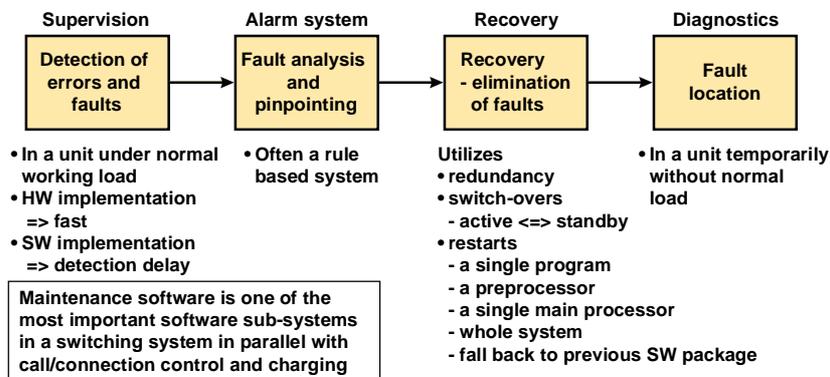
- **Maintainability $M(t)$** - probability that a system is returned to its correct functioning state during time t under the condition that it was faulty at time $t = 0$

MTTF, MTTR and MTBF

- **MTTF (Mean-Time-To-Failure)** - expected value of the time duration from the present to the next failure
- **MTTR (Mean-Time-To-Repair)** - expected value of the time duration from a fault until the system has been restored into a correct functioning state
- **MTBF (Mean-Time-Between-Failures)** - expected value of the time duration from occurrence of a fault until the next occurrence of a fault
 - **MTBF = MTTR + MTTF**

High availability of a switching system

- High availability of a switching system is obtained by maintenance software



Main types of redundancy

- **Hardware redundancy**
 - duplication (1+1) - need for "self-checking"-recovery blocks that detect their own faults
 - $n+r$ -principle (n active units and r standby units)
- **Software redundancy**
 - required always in telecom systems
- **Information redundancy**
 - parity bits, block codes, etc.
- **Time redundancy**
 - delayed re-execution of transactions

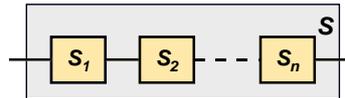
Modeling of reliability

- Combinatorial models
- Markov analysis
- Other modeling techniques (not covered here)
 - Fault tree analysis
 - Reliability block diagrams
 - Monte Carlo simulation

Combinatorial reliability

- A **serial system S** functions if and only if all its parts $S_i (1 \leq i \leq n)$ function

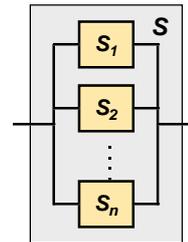
$$\Rightarrow R_s = \prod_{i=1}^n R_i \text{ and } F_s = (1 - R_s)$$



- Failures in sub-systems are supposed to be independent

- A **parallel (replicated) system** fails if all its sub-systems fail

$$\Rightarrow F_s = \prod_{i=1}^n (1 - R_i) \text{ and } R_s = 1 - F_s = 1 - \prod_{i=1}^n (1 - R_i)$$



- Reliability of a duplicated system ($R_i = R$) is $R_s = 1 - (1 - R)^2$

Combinatorial reliability example 1

- Calculate reliability R_s and failure probability F_s of system **S** given that failures in sub-systems S_i are independent and for some time interval it holds that

$$R_1 = 0.90, R_2 = 0.95 \text{ and } R_3 = R_4 = 0.80$$

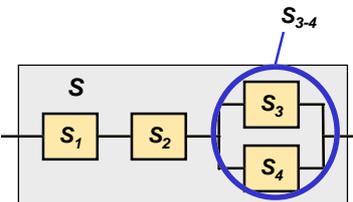
$$\Rightarrow R_s = \prod R_i = R_1 \times R_2 \times R_{3-4}$$

$$\Rightarrow R_{3-4} = 1 - \prod (1 - R_i) = 1 - (1 - R_3)(1 - R_4)$$

$$\Rightarrow R_s = R_1 \times R_2 \times [1 - (1 - R_3)(1 - R_4)]$$

$$\Rightarrow F_s = 1 - R_s = 1 - R_1 \times R_2 \times [1 - (1 - R_3)(1 - R_4)]$$

$$\Rightarrow R_s = 0.82 \text{ and } F_s = 0.18$$



Combinatorial reliability (cont.)

- A load sharing system functions if m of the total of n sub-systems function
- If failures in sub-systems S_i are independent then probability that the system fails is

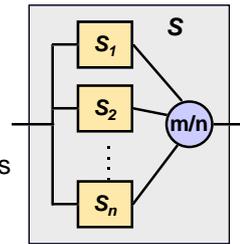
$$P(\text{fails}) = P(k < m)$$

and probability that it functions is

$$P(\text{functioning}) = P(k \geq m) = 1 - P(k < m)$$

where k is the number of functioning sub-systems

$$P(k \geq m) = \sum_{i=m}^n P(k=i) \quad \text{and} \quad P(k < m) = \sum_{i=0}^{m-1} P(k=i)$$



Combinatorial reliability example 2

- As an example, suppose we have a system having $m=2$ and $n=4$ and each of the four sub-systems have a different R , i.e. R_1, R_2, R_3 and R_4 , and failures in sub-systems S_i are independent

- Probability that the system fails is

$$P(\text{fails}) = P(k < 2) = \sum_{i=0}^1 P(k=i) = P(k=0) + P(k=1)$$

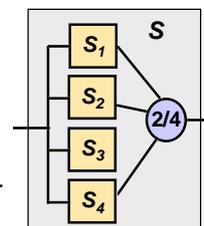
- $P(k=0)$ and $P(k=1)$ can be derived to be

$$P(k=0) = (1 - R_1)(1 - R_2)(1 - R_3)(1 - R_4)$$

$$P(k=1) = R_1(1 - R_2)(1 - R_3)(1 - R_4) + (1 - R_1)R_2(1 - R_3)(1 - R_4) + (1 - R_1)(1 - R_2)R_3(1 - R_4) + (1 - R_1)(1 - R_2)(1 - R_3)R_4$$

- If $R_1=0.9, R_2=0.95, R_3=0.85$ and $R_4=0.8$ then

$$R_s = 0.994 \quad \text{and} \quad F_s = 0.0058$$



Combinatorial reliability (cont.)

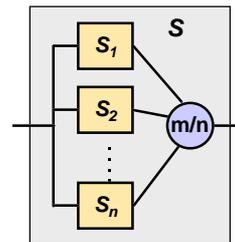
- If failures in sub-systems S_i of an m/n system are independent and $R_i = R$ for all $i \in [1, n]$ then the system is a Bernoulli system and binomial distribution applies

$$\Rightarrow R_s = \sum_{k=m}^n \binom{n}{k} R^k (1-R)^{n-k}$$

- For a system of $m/n = 2/3$

$$\Rightarrow R_{2/3} = \sum_{k=2}^3 \frac{3!}{k!(3-k)!} R^k (1-R)^{3-k} = 3R^2 - 2R^3$$

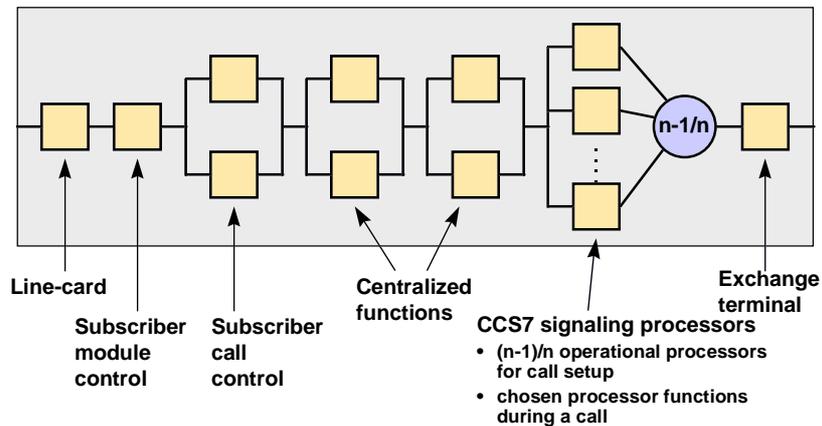
If for example $R = 0.9 \Rightarrow R_{2/3} = 0.972$



Computing MTTF

- $MTTF = \int_0^{\infty} R(t) dt$ - valid for any reliability distribution
- Single component with a constant failure rate (CFR) λ
 - $R(t) = e^{-\lambda t}$
 - $MTTF = 1/\lambda$
- Serial systems with n CFR components
 - $R_s(t) = R_1(t) \times R_2(t) \times \dots \times R_n(t) = e^{-(\lambda_1 + \lambda_2 + \dots + \lambda_n)t} = e^{-\lambda_s t}$
 - $\lambda_s = \lambda_1 + \lambda_2 + \dots + \lambda_n$
- $MTTF_s = 1/\lambda_s$
- $1/MTTF_s = 1/MTTF_1 + 1/MTTF_2 + \dots + 1/MTTF_n$

Telecom exchange reliability from subscriber's point of view



Premature release requirement $P \leq 2 \times 10^{-5}$ applied

Failure intensity

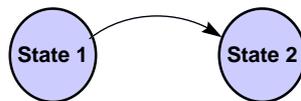
- Unit of failure intensity λ is defined to be $[\lambda] = \text{fit} = \text{number of faults} / 10^9 \text{ h}$
- Failure intensities for replaceable plug-in-units varies in the range 0.1 - 10 kfit
- Example:
 - if failure intensity of a line-card in an exchange is 2 kfit, what is its MTTF ?

$$\text{MTTF} = 1/\lambda = \frac{10^9 \text{ h}}{2000} = \frac{1\,000\,000 \text{ h}}{2 \times 24 \times 360} = 58 \text{ years}$$

Reliability modeling using Markov chains

Markov chains

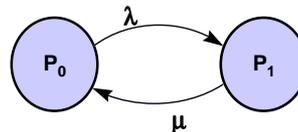
- A system is modeled as a set of states of transitions
- Each state corresponds to fulfillment of a set of conditions and each transition corresponds to an event in a system that changes from one state to another



- By using this method it is possible to find reliability behavior of a complex system having a number of states and non-independent failure modes

Markov chain modeling

- A set of states of transitions leads to a group of linear differential equations
- For a given modeling goal it is essential to choose a minimal set of states for equations to be easily solved
- By setting the derivatives of the probabilities to zero an asymptotic state is obtained if such exists



λ = failure intensity

μ = repair intensity (repair time is exponentially distributed)

P_i = probability of state i , e.g. $P_0 = R(t)$ and $P_1 = F(t)$,

Markov chain modeling (cont.)

- Probabilities (π_i) of the states and transition rates (λ_{ij}) between the states are tied together with the following formula

$$\pi\Lambda = 0$$

where

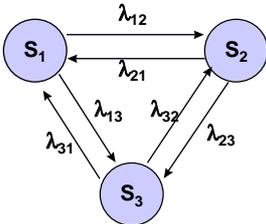
$$\pi = [\pi_1 \quad \pi_2 \quad \dots \quad \pi_n]$$

$$\Lambda = \begin{bmatrix} -(\lambda_{12} + \lambda_{13} + \dots) & \lambda_{12} & \lambda_{13} & \dots \\ \lambda_{21} & -(\lambda_{21} + \lambda_{23} + \dots) & \lambda_{23} & \dots \\ \lambda_{31} & \lambda_{32} & -(\lambda_{31} + \lambda_{32} + \dots) & \dots \\ \vdots & \vdots & \vdots & \ddots \end{bmatrix}$$

Markov chain modeling (cont.)

Example

$$\Lambda = \begin{bmatrix} -(\lambda_{12} + \lambda_{13}) & \lambda_{12} & \lambda_{13} \\ \lambda_{21} & -(\lambda_{21} + \lambda_{23}) & \lambda_{23} \\ \lambda_{31} & \lambda_{32} & -(\lambda_{31} + \lambda_{32}) \end{bmatrix}$$



$$\pi\Lambda = 0 \quad \text{and} \quad \pi = [\pi_1 \quad \pi_2 \quad \dots \quad \pi_n]$$

$$\begin{cases} -(\lambda_{12} + \lambda_{13})\pi_1 + \lambda_{12}\pi_2 + \lambda_{13}\pi_3 = 0 \\ \lambda_{21}\pi_1 - (\lambda_{21} + \lambda_{23})\pi_2 + \lambda_{23}\pi_3 = 0 \\ \lambda_{31}\pi_1 + \lambda_{32}\pi_2 - (\lambda_{31} + \lambda_{32})\pi_3 = 0 \end{cases}$$

Example of birth-death process

A switching system has two control computer, one on-line and one standby. The time interval between computer failures is exponentially distributed with mean t_f . In case of a failure, the standby computer replaces the failed one.

A single repair facility exist and repair times are exponentially distributed with mean t_r .

What fraction of time the system is out of use, i.e., both computers having failed?

The problem can be solved by using a three state birth-death model.



Example of birth-death process (cont.)

S₀ - both computer operable

S₁ - one computer failed

S₂ - both computer failed

$$\frac{1}{\pi_0} = \left[1 + \frac{1/t_r}{1/t_f} + \left(\frac{1/t_r}{1/t_f} \right)^2 \right] \Rightarrow \pi_0 = \frac{t_r^2}{t_r^2 + t_r t_f + t_f^2}$$

(probability that both computers have failed)

If $t_r/t_f = 10$, i.e. the average repair time is 10 % of the average time between failures, then $\pi_0 = 0.009009$ and both computer will be out of service 0.9 % of the time.

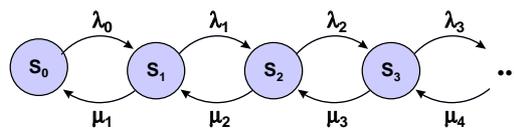
Additional reading of Markov chain modeling

Switching Technology S38.165
<http://www.netlab.hut.fi/opetus/s38165>

Markov chain modeling

A continuous-time Markov Chain is a stochastic process $\{X(t): t \geq 0\}$

- $X(t)$ can have values in $S = \{0, 1, 2, 3, \dots\}$
- Each time the process enters a state i , the amount of time it spends in that state before making a transition to another state has an exponential distribution with mean $1/\lambda_i$
- When leaving state i , the process moves to a state j with probability p_{ij} where $p_{ii} = 0$
- The next state to be visited after i is independent of the length of time spent in state i



Markov chain modeling (cont.)

Transition probabilities

$$p_{ij}(t) = P\{X(t+s) = j | X(s) = i\}$$

Continuous at $t=0$, with

$$\lim_{t \rightarrow 0} p_{ij}(t) = \begin{cases} 1 & \text{if } i = j \\ 0 & \text{if } i \neq j \end{cases}$$

Transition matrix is a function of time

$$P(t) = \begin{bmatrix} p_{11}(t) & p_{12}(t) & \dots \\ p_{21}(t) & \vdots & \\ \vdots & & \ddots \end{bmatrix}$$

Markov chain modeling (cont.)

Transition intensity:

$$\lambda_j(t) = -\frac{d}{dt} p_{jj}(0) \quad (\text{rate at which the process leaves state } j \text{ when it is in state } j)$$

$$\lambda_{ij}(t) = \frac{d}{dt} p_{ij}(0) = \lambda_i p_{ij} \quad (\text{transition rate into state } j \text{ when the process is in state } i)$$

The process, starting in state i , spends an amount of time in that state having exponential distribution with rate λ_i . It then moves to state j with probability

$$p_{ij} = \frac{\lambda_{ij}}{\lambda_i} \quad \forall i, j \quad \sum_{j=1}^n p_{ij} = \sum_{j=1}^n \frac{\lambda_{ij}}{\lambda_i} = \frac{\sum_{j=1}^n \lambda_{ij}}{\lambda_i} = 1 \quad \Rightarrow \quad \lambda_i = \sum_{j=1}^n \lambda_{ij}$$

Markov chain modeling (cont.)

Chapman-Kolmogorov equations:

$$p_{ij}(t+s) = \sum_{k \in S} p_{ik}(t) p_{kj}(s) \quad \forall i, j \in S$$

$$\forall s, t \geq 0$$

Since $p(t)$ is a continuous function

$$p_{ij}(\Delta t) = p_{ij}(0) + \frac{d}{dt} p_{ij}(0) \Delta t + o(\Delta t^2)$$

We have defined $\Rightarrow \lambda_{ij}(t) = \frac{d}{dt} p_{ij}(0)$

For $i \neq j$: $p_{ij}(\Delta t) = p_{ij}(0) + \lambda_{ij} \Delta t + o(\Delta t^2) \approx \lambda_{ij} \Delta t$ (for small Δt)

For $i=j$: $p_{ii}(\Delta t) = p_{ii}(0) + \lambda_{ii} \Delta t + o(\Delta t^2) \approx 1 + \lambda_{ii} \Delta t$ (for small Δt)

Markov chain modeling (cont.)

From Chapman-Kolmogorov equations:

$$p_{ij}(t + \Delta t) = \sum_k p_{ik}(t) p_{kj}(\Delta t) = p_{ij}(t) p_{jj}(\Delta t) + \sum_{k \neq j} p_{ik}(t) p_{kj}(\Delta t)$$

$$= p_{ij}(t) [1 + \lambda_{jj} \Delta t + o(\Delta t^2)] + \sum_{k \neq j} p_{ik}(t) [\lambda_{kj} \Delta t + o(\Delta t^2)]$$

$$p_{ij}(t + \Delta t) = p_{ij}(t) + \left[\sum_k p_{ik}(t) \lambda_{kj} \right] \Delta t + \left[\sum_k p_{ik}(t) \right] o(\Delta t^2)$$

$$\frac{p_{ij}(t + \Delta t) - p_{ij}(t)}{\Delta t} = \sum_k p_{ik}(t) \lambda_{kj} + \left[\sum_k p_{ik}(t) \right] \frac{o(\Delta t^2)}{\Delta t}$$

Taking the limit as $\Delta t \rightarrow 0$ $\frac{d}{dt} p_{ij}(t) = \sum_k p_{ik}(t) \lambda_{kj} \quad \forall i, j$

Markov chain modeling (cont.)

The process is described by the system of differential equations:

$$\frac{d}{dt} p_{ij}(t) = \sum_k p_{ik}(t) \lambda_{kj} \quad \forall i, j$$

which can be given in the form

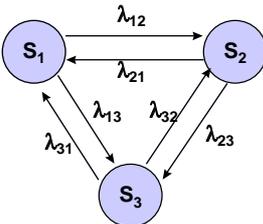
$$\frac{d}{dt} P(t) = P(t) \Lambda \quad \forall i, j \qquad \sum_j p_{ij}(t) = 1 \quad \forall i, t$$

$$\frac{d}{dt} \sum_j p_{ij}(t) = \frac{d}{dt} (1) = 0 \qquad \frac{d}{dt} \sum_j p_{ij}(t) = 0$$

$$\sum_j \lambda_{ij} = 0 \qquad \text{The sum of of each row of } \Lambda \text{ is zero !}$$

Markov chain modeling (cont.)

Example



$$\Lambda = \begin{bmatrix} -(\lambda_{12} + \lambda_{13}) & \lambda_{12} & \lambda_{13} \\ \lambda_{21} & -(\lambda_{21} + \lambda_{23}) & \lambda_{23} \\ \lambda_{31} & \lambda_{32} & -(\lambda_{31} + \lambda_{32}) \end{bmatrix}$$

The sum of of each row of Λ must be zero !

Markov chain modeling (cont.)

Steady state probabilities

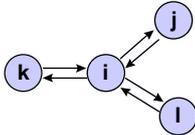
$$\lim_{t \rightarrow \infty} p_{ij}(t) = \pi_j \quad (\text{Independent of initial state } i)$$

Must be non-negative and must satisfy $\sum_{i=1}^n \pi_i = 1$

In case of continuous-time Markov chains balance equation used to determine π .

For each state i , the rate at which the system leaves the state must equal to the rate at which the system enters the state

$$\Rightarrow \lambda_i \pi_i = \lambda_{ji} \pi_j + \lambda_{ki} \pi_k + \lambda_{li} \pi_l$$



Markov chain modeling (cont.)

Balance equation

$$\left(\sum_{j \neq i} \lambda_{ij} \right) \pi_i = \sum_{k \neq i} \lambda_{ki} \pi_k \quad \forall i$$

Steady state distribution is computed by solving this system of equations

$$\left(\sum_{j \neq i} \lambda_{ij} \right) \pi_i = \sum_{k \neq i} \lambda_{ki} \pi_k \quad \forall i$$

$$\sum_{i=1}^n \pi_i = 1$$

Markov chain modeling (cont.)

An alternative derivation of the steady-state conditions begins with the differential equation describing the process:

$$\frac{d}{dt} p_{ij}(t) = \sum_k p_{ik}(t) \lambda_{kj} \quad \forall i, j$$

Suppose that we take the limit of each side as $t \rightarrow \infty$

$$\Rightarrow \lim_{t \rightarrow \infty} \frac{d}{dt} p_{ij}(t) = \lim_{t \rightarrow \infty} \sum_k p_{ik}(t) \lambda_{kj}$$

$$\Rightarrow \frac{d}{dt} \lim_{t \rightarrow \infty} p_{ij}(t) = \sum_k \lim_{t \rightarrow \infty} p_{ik}(t) \lambda_{kj}$$

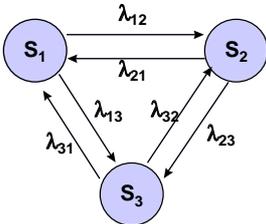
$$\Rightarrow \sum_k \pi_k \lambda_{kj} = 0 \quad \text{i.e. } \pi \Lambda = 0$$

Markov chain modeling (cont.)

Example

$$\Lambda = \begin{bmatrix} -(\lambda_{12} + \lambda_{13}) & \lambda_{12} & \lambda_{13} \\ \lambda_{21} & -(\lambda_{21} + \lambda_{23}) & \lambda_{23} \\ \lambda_{31} & \lambda_{32} & -(\lambda_{31} + \lambda_{32}) \end{bmatrix}$$

$$\pi \Lambda = 0 \quad \text{and} \quad \pi = [\pi_1 \quad \pi_2 \quad \dots \quad \pi_n]$$



$$\begin{cases} -(\lambda_{12} + \lambda_{13})\pi_1 + \lambda_{21}\pi_2 + \lambda_{31}\pi_3 = 0 \\ \lambda_{12}\pi_1 - (\lambda_{21} + \lambda_{23})\pi_2 + \lambda_{32}\pi_3 = 0 \\ \lambda_{13}\pi_1 + \lambda_{23}\pi_2 - (\lambda_{31} + \lambda_{32})\pi_3 = 0 \end{cases}$$